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- *EPIC*[™] (Enhanced-Performance Implanted CMOS) Process
- Operating Range 2-V to 5.5-V V_{CC}
- Latch-Up Performance Exceeds 250 mA Per JESD 17
- ESD Protection Exceeds 2000 V Per MIL-STD-883, Method 3015; Exceeds 200 V Using Machine Model (C = 200 pF, R = 0)
- Package Options Include Plastic Small-Outline (D), Shrink Small-Outline (DB), Thin Very Small-Outline (DGV), Thin Shrink Small-Outline (PW), and Ceramic Flat (W) Packages, Ceramic Chip Carriers (FK), and Standard Plastic (N) and Ceramic (J) DIPs

description

The 'AHC14 devices contain six independent inverters. These devices perform the Boolean function $Y = \overline{A}$.

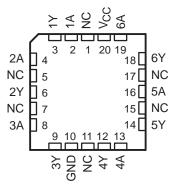
Each circuit functions as an independent inverter, but because of the Schmitt action, the inverters have different input threshold levels for positive-going (V_{T+}) and negative-going (V_{T-}) signals.

The SN54AHC14 is characterized for operation over the full military temperature range of -55° C to 125°C. The SN74AHC14 is characterized for operation from -40° C to 85°C.

SN54AHC14 J OR W PACKAGE
SN74AHC14D, DB, DGV, N, OR PW PACKAGE
(TOP VIEW)

	•			
1A [1Y [2A [2Y [3A [3Y [GND]	2 3 4 5	σ	12 11] V _{CC}] 6A] 6Y] 5A] 5Y] 4A] 4Y

SN54AHC14 . . . FK PACKAGE (TOP VIEW)



NC - No internal connection

FUNCTION TABLE (each inverter)							
INPUT A	OUTPUT Y						
Н	L						
L	Н						



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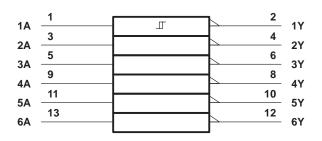
PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.



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logic symbol[†]



[†] This symbol is in accordance with ANSI/IEEE Std 91-1984 and IEC Publication 617-12. Pin numbers shown are for the D, DB, DGV, J, N, PW, and W packages.

logic diagram (positive logic)



absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[‡]

‡ Stresses beyond those listed under "absolute maximum ratings" may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under "recommended operating conditions" is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

NOTES: 1. The input and output voltage ratings may be exceeded if the input and output current ratings are observed.

2. The package thermal impedance is calculated in accordance with JESD 51.



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recommended operating conditions (see Note 3)

			SN54A	N54AHC14 SN74AHC14			UNIT
			MIN	MIN MAX MIN MAX 2 5.5 2 5.5 0 5.5 0 5.5 0 VCC 0 VCC -50 -50 -50 -4 -4 -8	UNIT		
Vcc	Supply voltage		2	5.5	2	5.5	V
VI	Input voltage		0	5.5	0	5.5	V
Vo	Output voltage		0	VCC	0	VCC	V
	High-level output current	$V_{CC} = 2 V$		-50		-50	μA
ЮН		V_{CC} = 3.3 V ± 0.3 V		-4		-4	mA
		V_{CC} = 5 V ± 0.5 V		-8		-8	IIIA
		$V_{CC} = 2 V$		50		50	μΑ
IOL	Low-level output current	V_{CC} = 3.3 V ± 0.3 V		4		4	mA
	$V_{CC} = 5 V \pm 0.5 V$			8		8	ШA
ТА	Operating free-air temperature		-55	125	-40	85	°C

NOTE 3: All unused inputs of the device must be held at V_{CC} or GND to ensure proper device operation. Refer to the TI application report, Implications of Slow or Floating CMOS Inputs, literature number SCBA004.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

PARAMETER	TEST CONDITIONS	Vee	$T_{A} = 25^{\circ}C \qquad SN54AHC14$ $MIN TYP MAX MIN MAX$	HC14	SN74A	HC14	UNIT			
PARAMETER	TEST CONDITIONS	Vcc	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
V _{T+}		3 V	1.2		2.2	1.2	2.2	1.2	2.2	
Positive-going		4.5 V	1.75		3.15	1.75	3.15	1.75	3.15	V
input threshold voltage		5.5 V	2.15		3.85	2.15	3.85	2.15	3.85	
V _T _		3 V	0.9		1.9	0.9	1.9	0.9	1.9	
Negative-going		4.5 V	1.35		2.75	1.35	2.75	1.35	2.75	V
input threshold voltage		5.5 V	1.65		3.35	1.65	3.35	1.65	3.35	
		3 V	0.3		1.2	0.3	1.2	0.3	1.2	
		4.5 V	0.4		1.4	0.4	1.4	0.4	1.4	V
Hysteresis (V _{T+} – V _{T–})		5.5 V	0.5		1.6	0.5	1.6	0.5	1.6	
		2 V	1.9	2		1.9		1.9		
	I _{OH} = -50 μA	3 V	2.9	3		2.9		2.9		
ΔV _T Hysteresis (V _{T+} – V _T _) V _{OH}		4.5 V	4.4	4.5		4.4		4.4		V
	$I_{OH} = -4 \text{ mA}$	3 V	2.58			2.48		2.48		
	I _{OH} = -8 mA	4.5 V	3.94			3.8		3.8		
		2 V			0.1		0.1		0.1	
	I _{OL} = 50 μA	3 V			0.1		0.1		0.1	
VOL		4.5 V			0.1		0.1		0.1	V
VOL	I _{OL} = 4 mA	3 V			0.36		0.5		0.44	
	I _{OL} = 8 mA	4.5 V			0.36		0.5		0.44	
lj	$V_I = V_{CC}$ or GND	5.5 V			±0.1		±1		±1	μA
ICC	$V_{I} = V_{CC} \text{ or } GND, \qquad I_{O} = 0$	5.5 V			2		20		20	μA
Ci	$V_{I} = V_{CC}$ or GND	5 V		2	10				10	pF



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switching characteristics over recommended operating free-air temperature range, V_{CC} = 3.3 V \pm 0.3 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	T,	ק = 25°C	;	SN54A	HC14	SN74A	HC14	UNIT
	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT
^t PLH	A	V	C _I = 15 pF		8.3*	12.8*	1*	15*	1	15	20
^t PHL		T	CL = 15 pr		8.3*	12.8*	1*	15*	1	15	ns
^t PLH	A	V	$C_{\rm L} = 50 \rm pF$		10.8	16.3	1	18.5	1	18.5	20
^t PHL		T	C _L = 50 pF		10.8	16.3	1	18.5	1	18.5	ns

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

switching characteristics over recommended operating free-air temperature range, V_{CC} = 5 V \pm 0.5 V (unless otherwise noted) (see Figure 1)

PARAMETER	FROM	то	LOAD	Т	₄ = 25°C	;	SN54A	HC14	SN74A	HC14	UNIT									
	(INPUT)	(OUTPUT)	CAPACITANCE	MIN	TYP	MAX	MIN	MAX	MIN	MAX	UNIT									
^t PLH	A	V	Ci - 15 pE		5.5*	8.6*	1*	10*	1	10	20									
^t PHL		A f	Т	Т			1	1	Ι	I	I	C _L = 15 pF			5.5*	8.6*	1*	10*	1	10
^t PLH	A	v	C _I = 50 pF		7	10.6	1	12	1	12	ns									
^t PHL		1	CL = 30 pr		7	10.6	1	12	1	12	115									

* On products compliant to MIL-PRF-38535, this parameter is not production tested.

noise characteristics, V_{CC} = 5 V, C_L = 50 pF, T_A = 25°C (see Note 4)

	PARAMETER	SN	UNIT		
		MIN	TYP	MAX	UNIT
V _{OL(P)}	Quiet output, maximum dynamic V _{OL}		0.8		V
VOL(V)	Quiet output, minimum dynamic V _{OL}		-0.4		V
VOH(V)	Quiet output, minimum dynamic V _{OH}		4.6		V
VIH(D)	High-level dynamic input voltage	3.5			V
V _{IL(D)}	Low-level dynamic input voltage			1.5	V

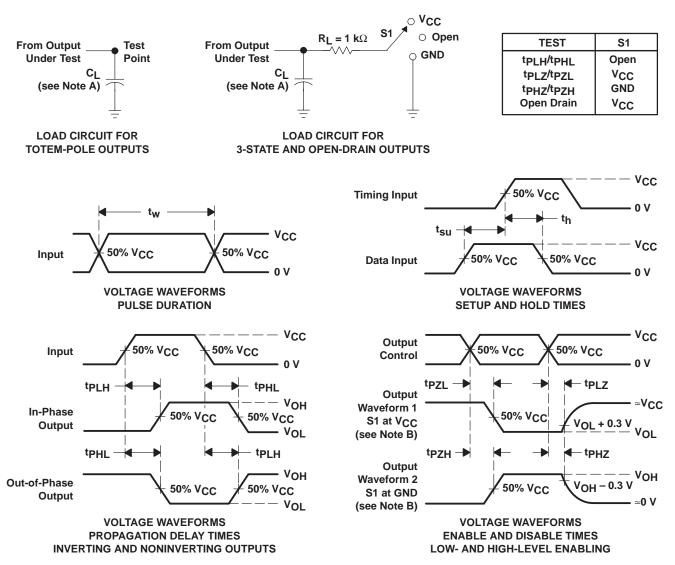
NOTE 4: Characteristics are for surface-mount packages only.

operating characteristics, $V_{CC} = 5 V$, $T_A = 25^{\circ}C$

	PARAMETER		ONDITIONS	TYP	UNIT
C _{pd}	Power dissipation capacitance	No load,	f = 1 MHz	9	pF



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PARAMETER MEASUREMENT INFORMATION

NOTES: A. CL includes probe and jig capacitance.

- B. Waveform 1 is for an output with internal conditions such that the output is low except when disabled by the output control. Waveform 2 is for an output with internal conditions such that the output is high except when disabled by the output control.
- C. All input pulses are supplied by generators having the following characteristics: PRR \leq 1 MHz, Z_O = 50 Ω , t_f \leq 3 ns, t_f \leq 3 ns.
- D. The outputs are measured one at a time with one input transition per measurement.

Figure 1. Load Circuit and Voltage Waveforms



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